



# **TEST REPORT**

**Product** : Portable Bluetooth Speaker

Trade mark :



Model/Type reference : Ambush Serial number : N/A

Ratings : Charging input: 5V==, 500mA

lithium Battery: 3,7V== 1150mAh, IPX0, Class III

FCC ID : Y22-SK2013008

Report number : EESZG06270006-1

Date : Jul. 18, 2014
Regulations : See below

Test Standards			Results
	5 Subpart C 15.247: 20	13	PASS

Prepared for:

Skullcandy

1441 W. Ute Blvd Suite 250 Park City, UT 84098 United States

Prepared by:

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Tested by: And Men Review

Approved by: \_\_\_\_\_ Date: \_\_\_\_\_ Jul. 18, 2014

Check No.: 1702001562



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	ans not applicable.	
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## 1. GENERAL INFORMATION

Applicant: Skullcandy

1441 W. Ute Blvd Suite 250 Park City, UT 84098 United States

Manufacturer:

1441 W. Ute Blvd Suite 250 Park City, UT 84098 United States

FCC ID: Y22-SK2013008

**Product:** Portable Bluetooth Speaker

Model/Type reference: **Ambush** 

Trade mark:

Serial Number: N/A

**Report Number:** EESZG06270006-1

Sample Received Date: Jun. 28, 2014

Sample tested Date: Jun. 28, 2014 to Jul. 18, 2014

The above equipment was tested by Centre Testing International (Shenzhen) Corporation for compliance with the requirements set forth in the IC/FCC Rules and the measurement procedure according to ANSI C63.4:2009.

## 2. TEST SUMMARY

No.	Test Item Rule		Test Result	
1	20dB / 99% Bandwidth	FCC 15.247(a)(1) & RSS-Gen 4.6.1	PASS	
2	Carrier Frequency Separation	FCC15.247(a)(1) & RSS-210 A8.1(b)	PASS	
3	Number of Hopping Frequency	FCC 15.247(a)(iii) & RSS-210 A8.4(2)	PASS	
4	Time of Occupancy (Dwell Time)	FCC 15.247(a)(iii) & RSS-210 A8.1(d)	PASS	
5	Maximum Peak Conducted Output Power	FCC 15.247(b)(1) & RSS-210 A8.1(b)	PASS	
6	Conducted Bandedge Emission / Conducted Spurious Emission	FCC PART15.247(d) & RSS-210 A8.5	PASS	
7	Radiated Bandedge Emission / Radiated Spurious Emission	FCC PART15.247(d) & RSS-210 A8.5	PASS	
8	AC Conducted Emission	FCC PART15.207 & RSS-Gen 7.2.4	PASS	
9	Antenna Requirements *	FCC PART15.203 & RSS-Gen 7.1.2	PASS (See Notes)	

<sup>\*:</sup> According to Section 15.203 and RSS-Gen 7.1.2, an intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The EUT has a built in antenna which is a short wire solder on the PCB, this is permanently attached antenna and meets the requirements of this section.





# 3. PRODUCT INFORMATION

Items	Description
Rating	Charging input: 5V===, 500mA lithium Battery: 3,7V=== 1150mAh, IPX0, Class III
Type of Modulation	GFSK (1Mbps) , π/4-DQPSK (2Mbps), 8DPSK (3Mbps)
Antenna Type	Integral antenna
Frequency Range	2402 ~ 2480 MHz
Gain	0dBi

# 4. MEASUREMENT UNCERTAINTY

This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

Measur	Measurement items		
Conducted Emission Test	(C)	(6,2,3)	3.2 dB
Radiated Emissions / Bandedge Em	nission		4.5 dB

# 5. TEST EQUIPMENT LIST

1201 2ggii M2itti 2i01				
Manufacturer	Model	Serial No.	Due Date	
ETS-LINDGREN	FACT-3	3510	07/12/2016	
Agilent	E4443A	MY45300910	01/15/2015	
R&S	ESCI	100435	07/19/2014	
schwarzbeck	VULB 9163	618	06/25/2015	
ETS-LINGREN	2090	00057230	N/A	
ETS-LINGREN	3117	00057407	07/19/2014	
Agilent	8449B	3008A02425	03/19/2015	
R&S	FSP40	100416	07/06/2015	
R&S	ESCI	100009	07/19/2014	
R&S	ENV216	100098	07/19/2014	
	Manufacturer ETS-LINDGREN Agilent R&S schwarzbeck ETS-LINGREN ETS-LINGREN Agilent R&S R&S	ManufacturerModelETS-LINDGRENFACT-3AgilentE4443AR&SESCIschwarzbeckVULB 9163ETS-LINGREN2090ETS-LINGREN3117Agilent8449BR&SFSP40R&SESCI	Manufacturer         Model         Serial No.           ETS-LINDGREN         FACT-3         3510           Agilent         E4443A         MY45300910           R&S         ESCI         100435           schwarzbeck         VULB 9163         618           ETS-LINGREN         2090         00057230           ETS-LINGREN         3117         00057407           Agilent         8449B         3008A02425           R&S         FSP40         100416           R&S         ESCI         100009	

# 6. SUPPORT EQUIPMENT LIST

Device Type	Brand	Model	Series No.	Data Cable	Remark
Notebook	DELL	Vostro 3400	GYQTVP1	N/A	FCC DOC
Mouse	L.Selectron	M004	02284699	Un-shielded 1.2M	FCC DOC















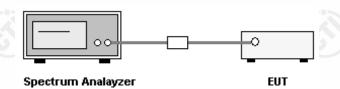
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# 7. 20dB / 99% Bandwidth Measurement

#### 7.1. LIMITS

None

#### 7.2. BLOCK DIAGRAM OF TEST SETUP



### 7.3. TEST PROCEDURE

- 1. The RF output of EUT was connected to the spectrum analyzer by RF cable. The path loss was compensated to the results for each measurement.
- 2. Set to the maximum power setting and enable the EUT transmit continuously.
- 3. Use the following spectrum analyzer settings for 20dB Bandwidth measurement. Span = approximately 2 to 3 times the 20 dB bandwidth, centered on a hopping channel; RBW ≥ 1% of the 20 dB bandwidth; VBW ≥ RBW; Sweep = auto; Detector function = peak; Trace = max hold.
- 4. Use the following spectrum analyzer settings for 99 % Bandwidth measurement. For 99% Bandwidth measurement, the RBW=30 kHz, and VBW = 100 kHz. Sweep = auto; Detector function = peak. Trace = max hold.
- 5. Measure and record the results in the test report.

#### 7.4. TEST RESULT

The test data of worst case are below:

#### GFSK:

Frequency (MHz)	20dB BW (MHz)	99% BW (MHz)
2402	0.828	0.840
2441	0.810	0.834
2480	0.810	0.840

#### Π/4-DQPSK:

Frequency (MHz)	20dB BW (MHz)	99% BW (MHz)
2402	1.218	1.170
2441	1.218	1.182
2480	1.224	1.188

#### 8DPSK:

Frequency (MHz)	20dB BW (MHz)	99% BW (MHz)
2402	1.212	1.158
2441	1.212	1.164
2480	1.212	1.170





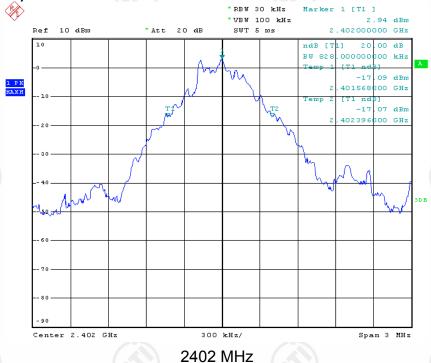


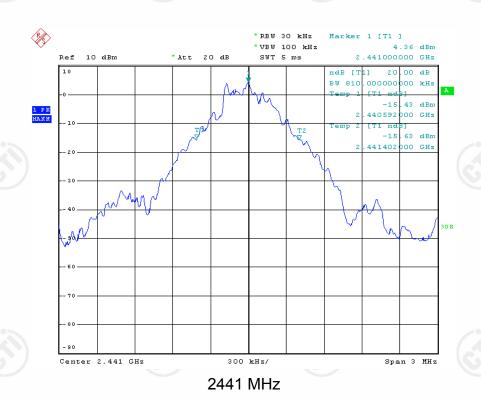




Please see the following plots (worst case):

# GFSK (20dB BW):





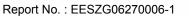


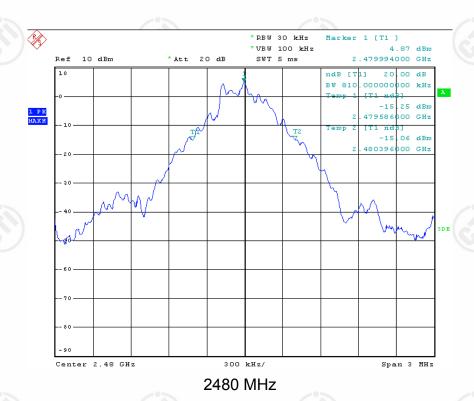






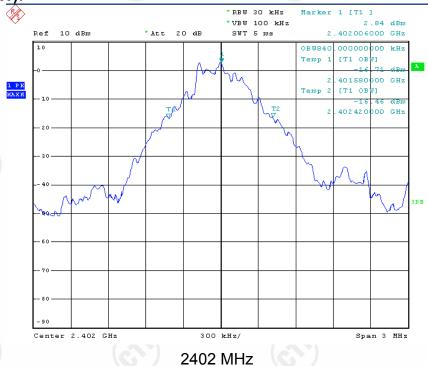






# GFSK (99% BW):

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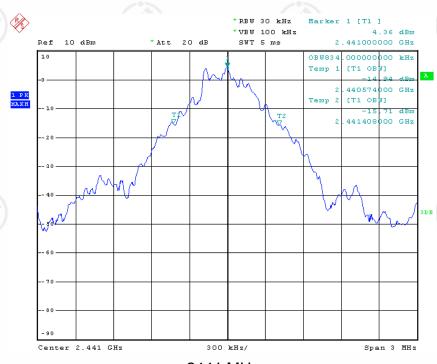




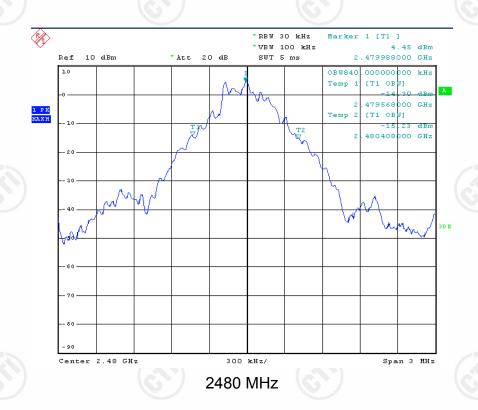


















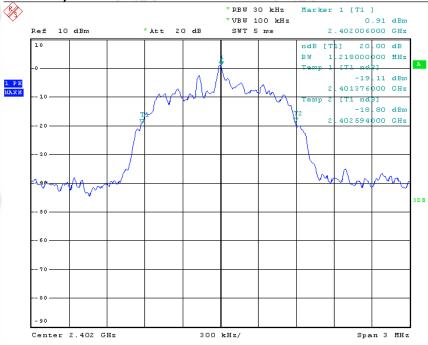




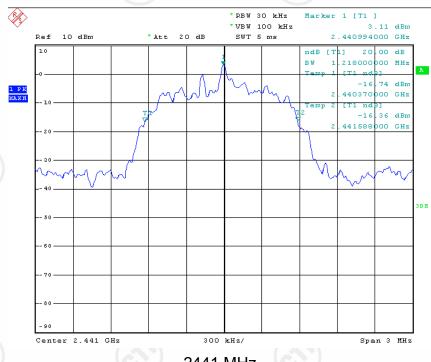


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# Π/4-DQPSK (20dB BW):



2402 MHz



2441 MHz



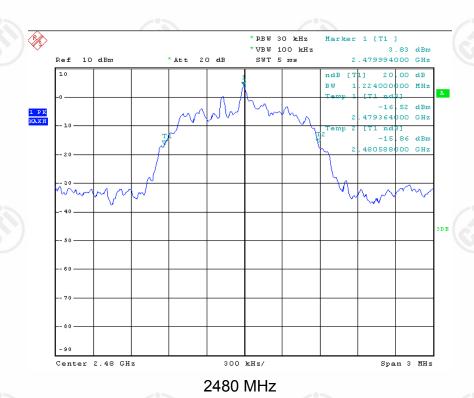




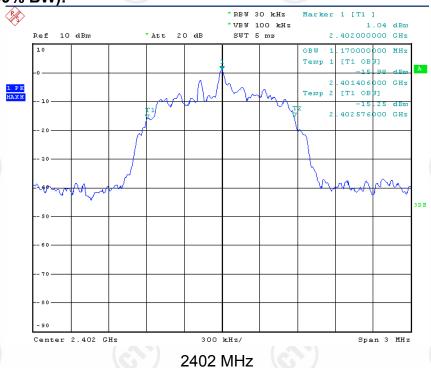




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# П/4-DQPSK (99% BW):





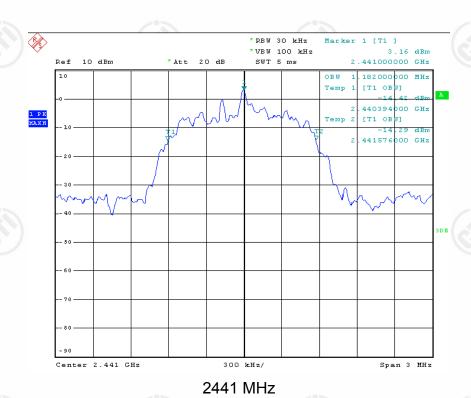
















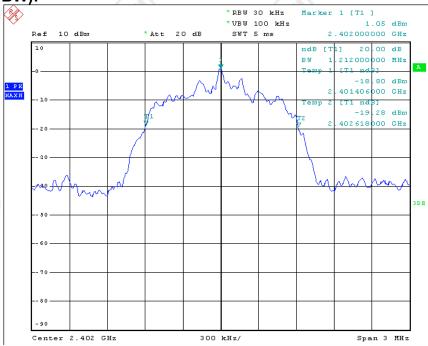






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# 8DPSK (20dB BW):



2402 MHz





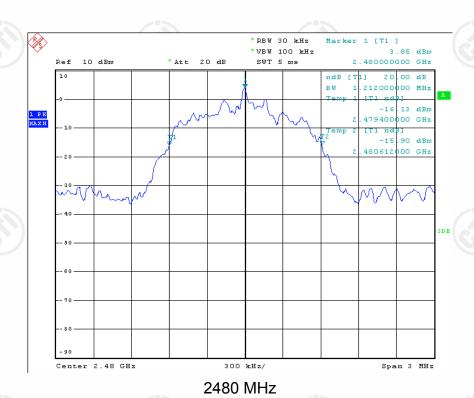




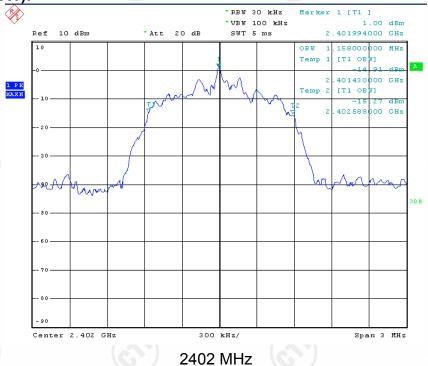








# 8DPSK (99% BW):





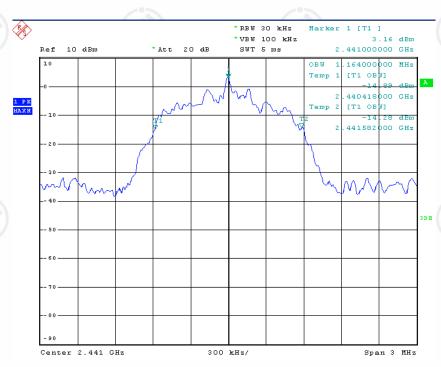




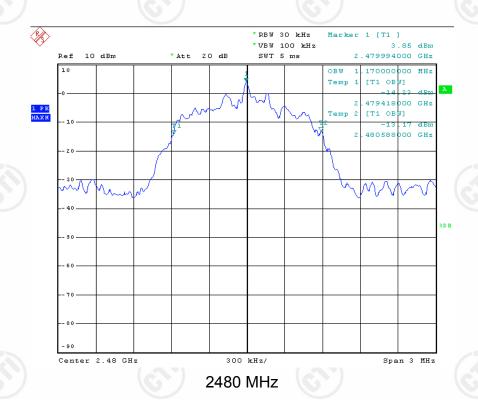






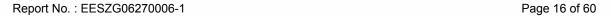










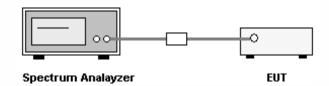


## 8. CARRIER FREQUENCY SEPARATION

#### 8.1. LIMITS

Frequency hopping systems operating in the 2400-2483.5MHz band may have hopping channel carrier frequencies that are separated by 25 kHz or two-thirds of the 20 dB bandwidth of the hopping channel, whichever is greater, provided the systems operate with an output power no greater than 125mW.

### 8.2. BLOCK DIAGRAM OF TEST SETUP



#### 8.3. TEST PROCEDURE

- 1. The RF output of EUT was connected to the spectrum analyzer by RF cable. The path loss was compensated to the results for each measurement.
- 2. Set to the maximum power setting and enable the EUT transmit continuously.
- 3. Enable the EUT hopping function.
- 4. Use the following spectrum analyzer settings: Span = wide enough to capture the peaks of two adjacent channels; RBW ≥ 1% of the span; VBW ≥ RBW; Sweep = auto; Detector function = peak; Trace = max hold.
- 5. Measure and record the results in the test report.

### 8.4. TEST RESULT

Carrier Frequency Separation: 1 MHz







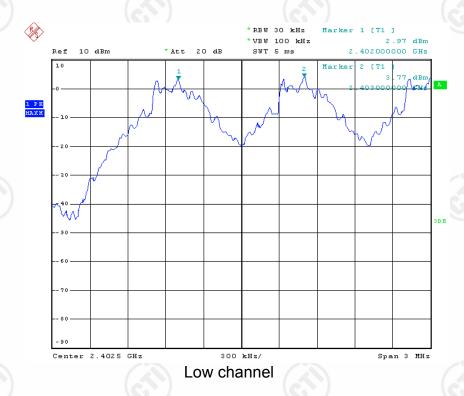


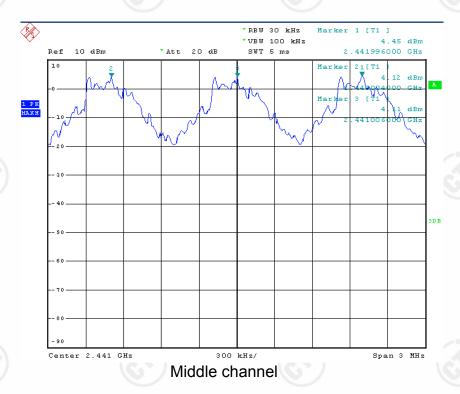


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# Please see the following plots (worst case):

# **GFSK:**







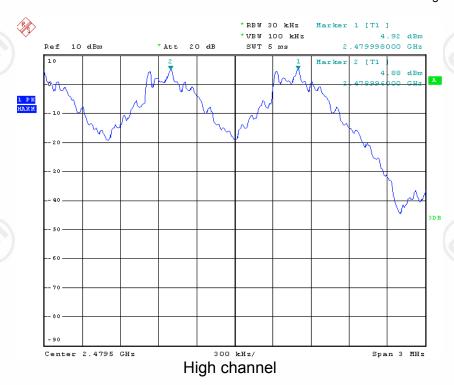




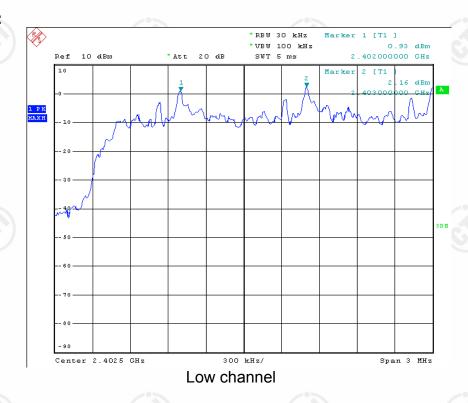




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# Π/4-DQPSK:







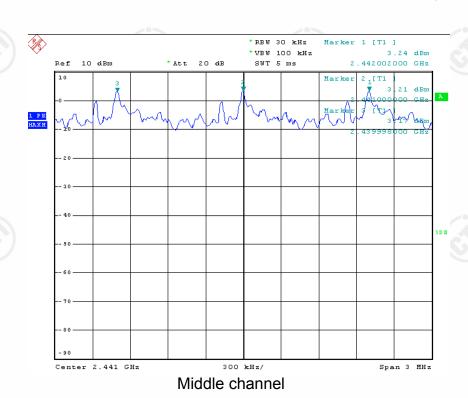


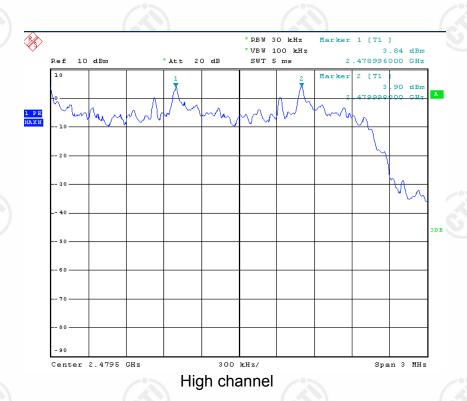






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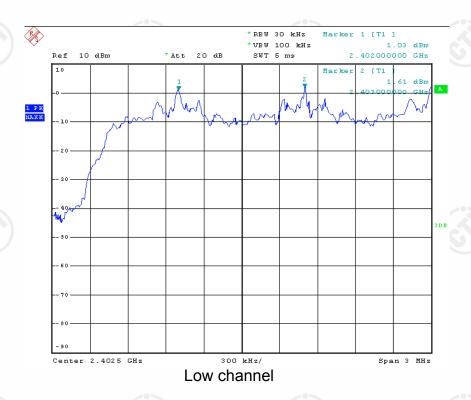


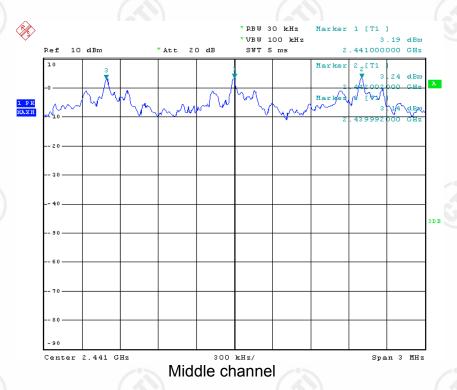




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## 8DPSK:







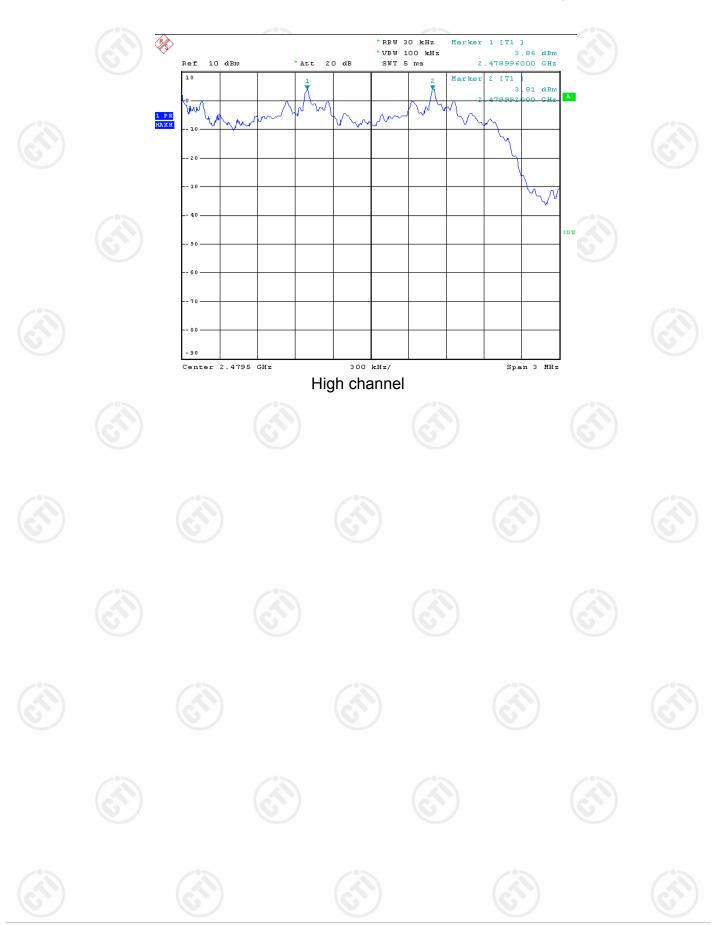








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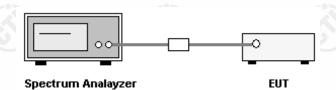
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### 9. NUMBER OF HOPPING FREQUENCY

#### 9.1. LIMITS

Frequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 channels.

### 9.2. BLOCK DIAGRAM OF TEST SETUP

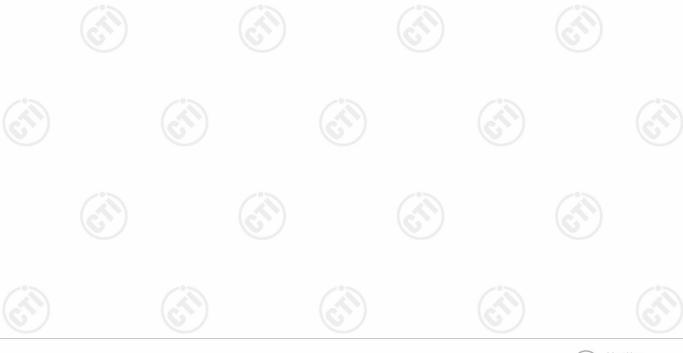


#### 9.3. TEST PROCEDURE

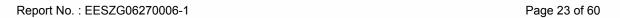
- 1. The RF output of EUT was connected to the spectrum analyzer by RF cable. The path loss was compensated to the results for each measurement.
- 2. Set to the maximum power setting and enable the EUT transmit continuously.
- 3. Enable the EUT hopping function.
- 4. Use the following spectrum analyzer settings: Span = the frequency band of operation; RBW ≥ 1% of the span; VBW ≥ RBW; Sweep = auto; Detector function = peak; Trace = max hold.
- 5. The number of hopping frequency used is defined as the number of total channel.
- 6. Record the measurement data derived from spectrum analyzer.

#### 9.4. TEST RESULT

Number of Hopping Frequency is 79, with frequency space = 1MHz.

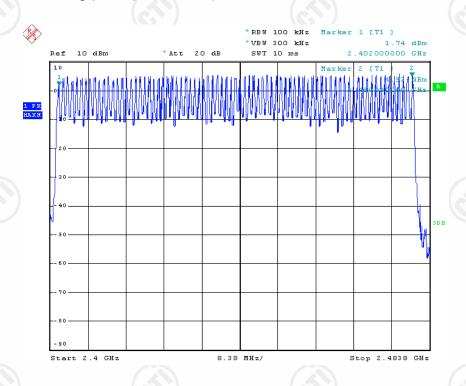






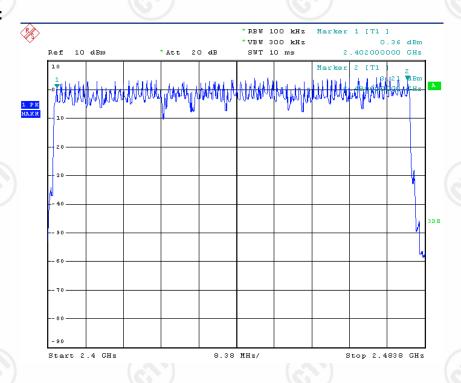
# Please see the following plots (worst case):

# **GFSK:**



# Π/4-DQPSK:

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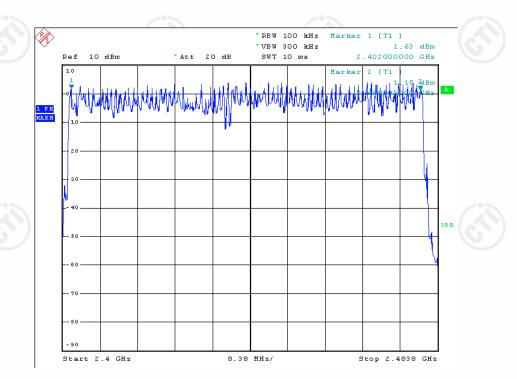






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## 8DPSK:



























































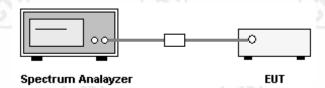
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# 10. TIME OF OCCUPANCY (DWELL TIME)

#### **10.1. LIMITS**

The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed.

### 10.2. BLOCK DIAGRAM OF TEST SETUP



#### 10.3. TEST PROCEDURE

1. The RF output of EUT was connected to the spectrum analyzer by RF cable.

The path loss was compensated to the results for each measurement.

- 2. Set to the maximum power setting and enable the EUT transmit continuously.
- 3. Enable the EUT hopping function.
- 4. Use the following spectrum analyzer settings: Span = zero span, centered on a hopping channel; RBW = 1 MHz; VBW ≥ RBW; Sweep = as necessary to capture the entire dwell time per hopping channel; Detector function = peak; Trace = max hold.
- 5. Measure and record the results in the test report.

#### 10.4. TEST RESULT

The test data of worst case (GFSK mode) are below:

		`				
Frequency (MHz)			Dwell Time (ms)	Limit (s)	Result (Pass / Fail)	
	DH1	0.42	134.40			
2402	DH3	1.68	268.80	0.4	Pass	
	DH5	2.94	313.61			
0	DH1	0.425	136.00	,		
2441	DH3	1.68	268.80	0.4	Pass	
6-	DH5	2.92	311.48		-0	
	DH1	0.425	136.00			
2480	DH3	1.68	268.80	0.4	Pass	
	DH5	2.96	315.74			

#### Remark:

DH1 Packet permit maximum 1600 / 79 / 2 = 10.12 hops per second in each channel (1 time slot RX, 1 time slot TX). So, total hops is  $10.12 \times 31.6 = 320$ 

DH3 Packet permit maximum 1600 / 79 / 4 = 5.06 hops per second in each channel (3 time slots RX, 1 time slot TX). So, total hops is  $5.06 \times 31.6 = 160$ 

DH5 Packet permit maximum 1600/79/6 = 3.37 hops per second in each channel (5 time slots RX, 1 time slot TX). So, total hops is  $3.37 \times 31.6 = 106.67$ 

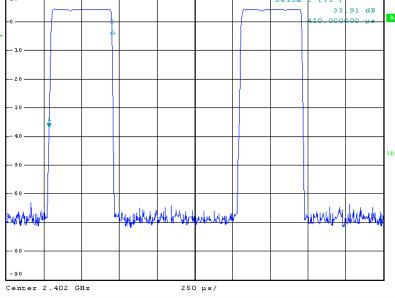




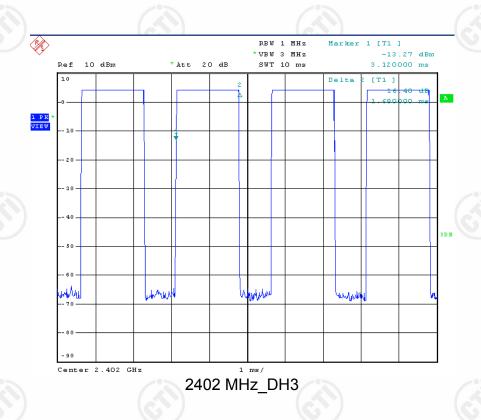








2402 MHz DH1





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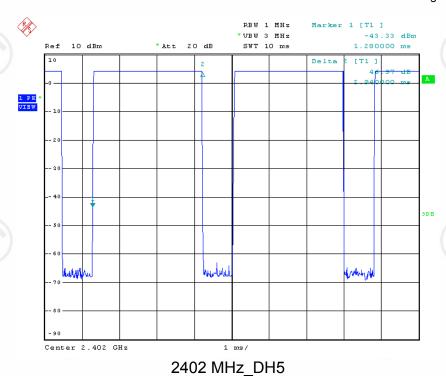


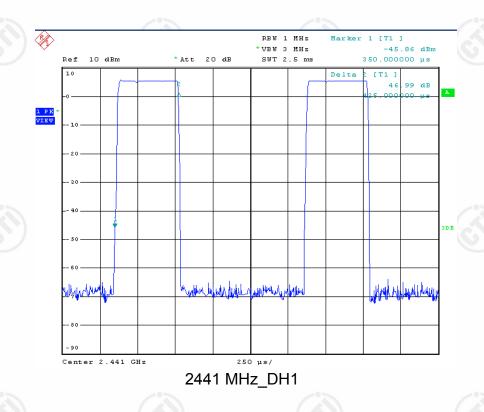






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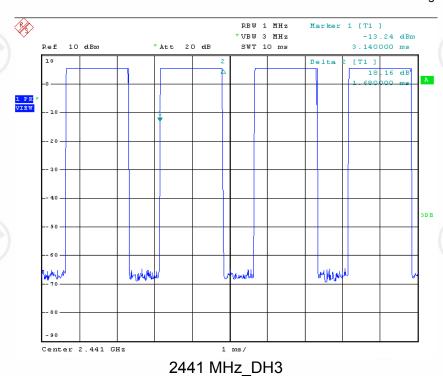


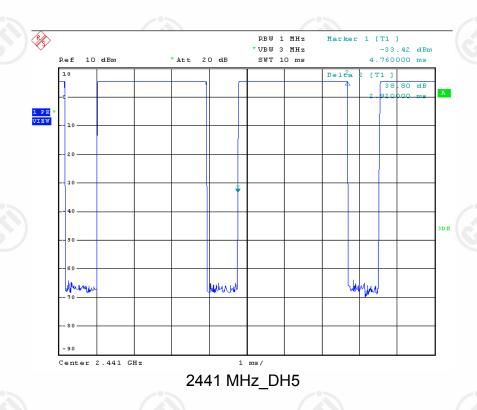














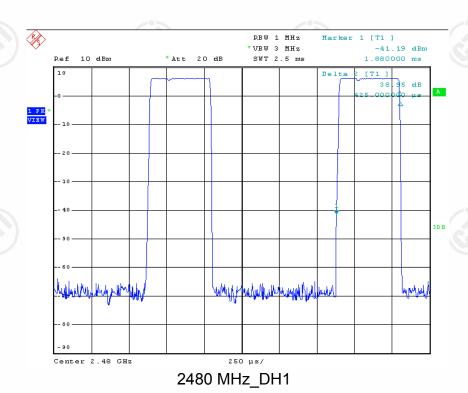


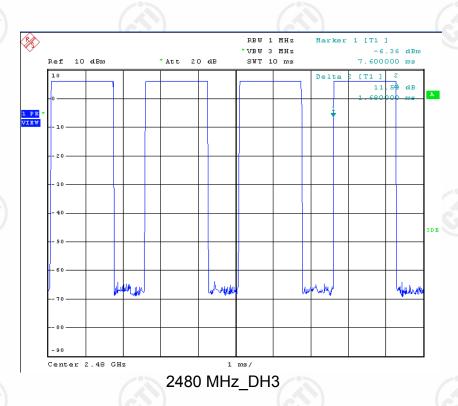






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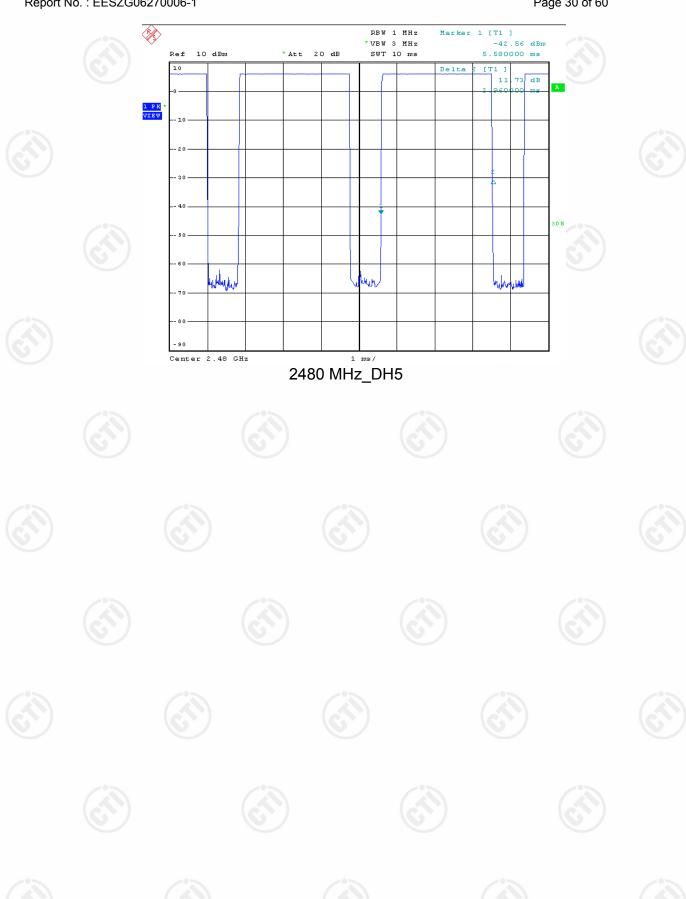








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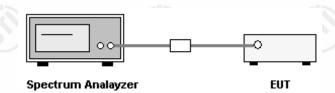


# 11. MAXIMUM PEAK CONDUCTED OUTPUT POWER MEASUREMENT

## **11.1. LIMITS**

The limit for peak output power is 1Watt (30 dBm).

# 11.2. BLOCK DIAGRAM OF TEST SETUP



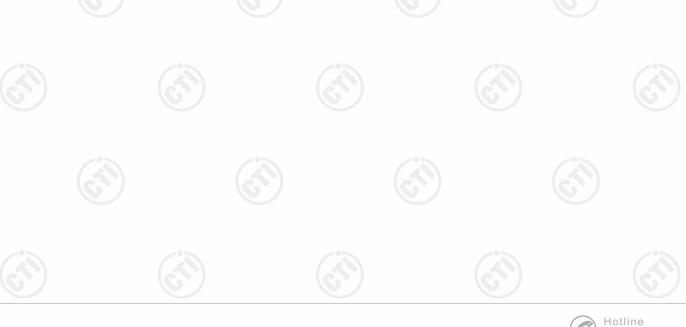
#### 11.3. TEST PROCEDURE

- 1. The RF output of EUT was connected to the power meter by RF cable and attenuator. The path loss was compensated to the results for each measurement.
- 2. Set to the maximum power setting and enable the EUT transmit continuously.
- 3. Measure the conducted output power with cable loss and record the results in the test report.
- 4. Measure and record the results in the test report.

### 11.4. TEST RESULT

All the modes of GFSK,  $\pi/4$ -DQPSK and 8DPSK have been tested. The worst case is GFSK mode, and the worst data of GFSK mode are below:

Frequency (MHz)	Peak Power (dBm)	Limit (dBm)	Result (Pass / Fail)
2402	4.41	30	Pass
2441	5.64	30	Pass
2480	6.03	30	Pass





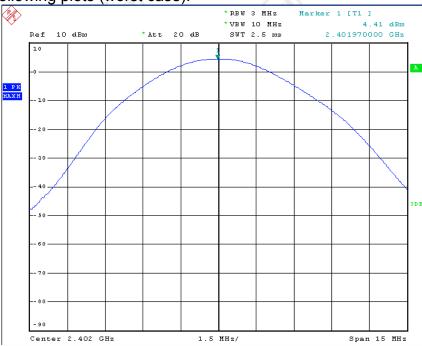






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# Please see the following plots (worst case):



2402MHz





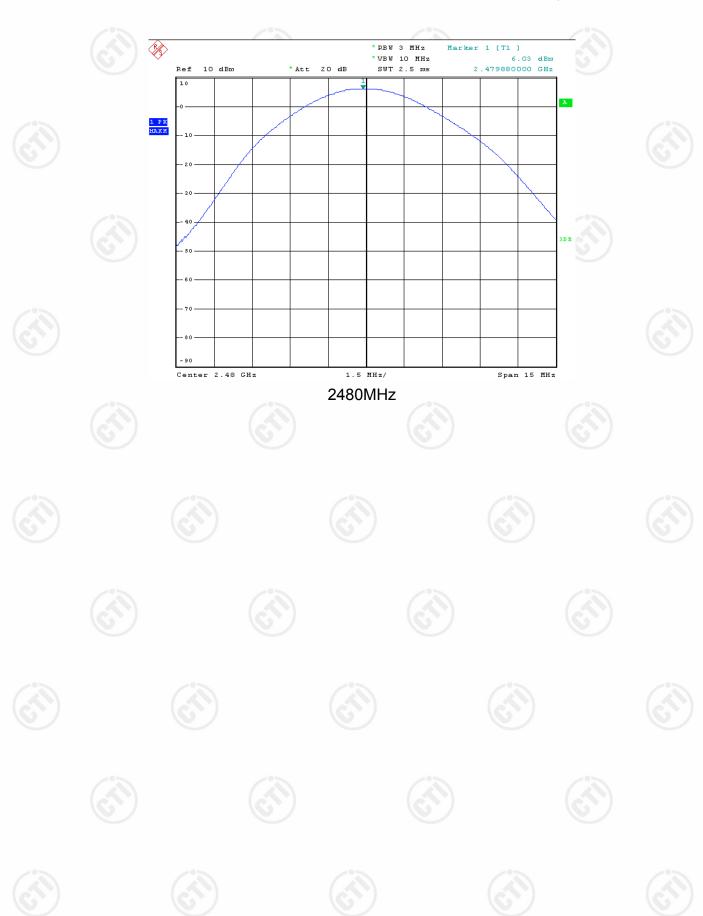








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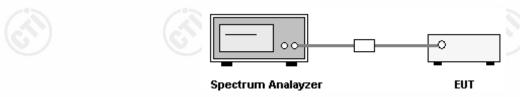


### 12. CONDUCTED BANDEDGE EMISSION MEASUREMENT

#### **12.1. LIMITS**

In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in §15.209(a) is not required. In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in §15.209(a).

## 12.2. BLOCK DIAGRAM OF TEST SETUP

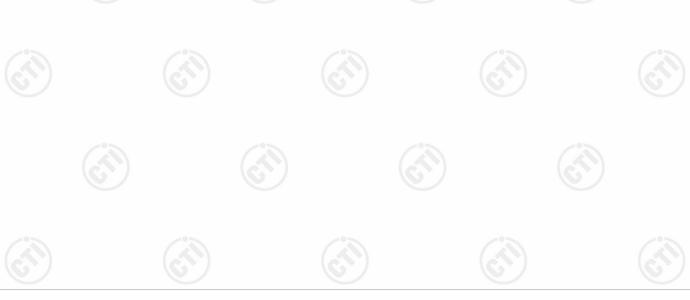


#### 12.3. TEST PROCEDURE

- 1. Set to the maximum power setting and enable the EUT transmit continuously.
- 2. Set RBW = 100 kHz, VBW = 300 kHz (≥ RBW). Band edge emissions must be at least 20 dB down from the highest emission level within the authorized band as measured with a 100 kHz RBW.
- 3. Enable hopping function of the EUT and then repeat step 1 and 2.
- 4. Measure and record the results in the test report.

#### 12.4. TEST RESULT

Pass.







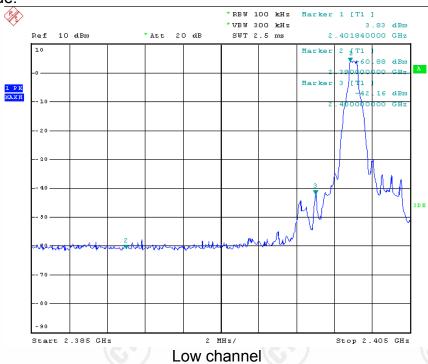


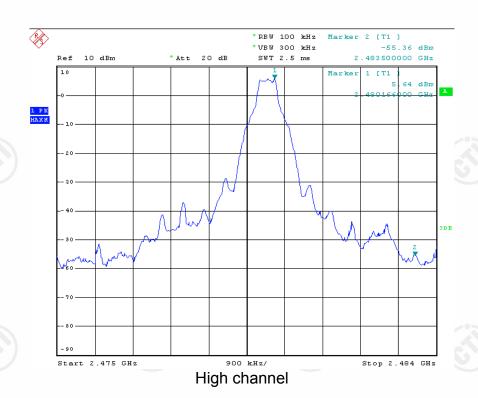


The test data of worst case are below:

## **GFSK:**

Hopping off mode:









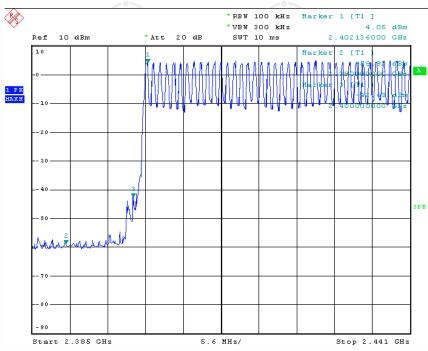




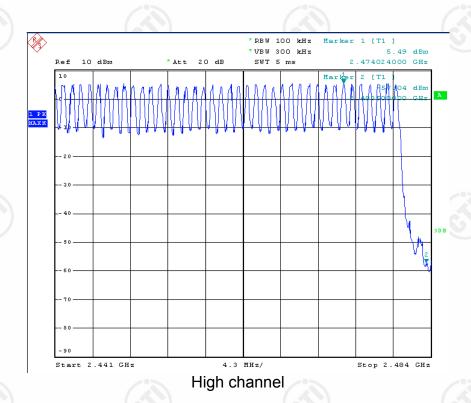


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# Hopping mode:













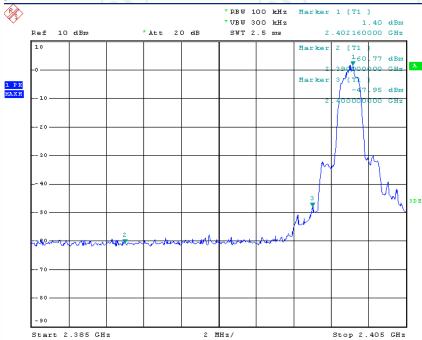


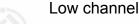


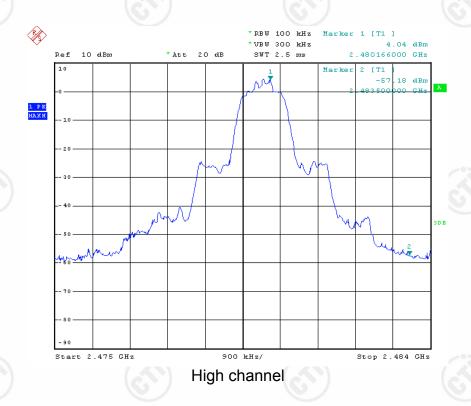


### Π/4-DQPSK:

Hopping off mode:











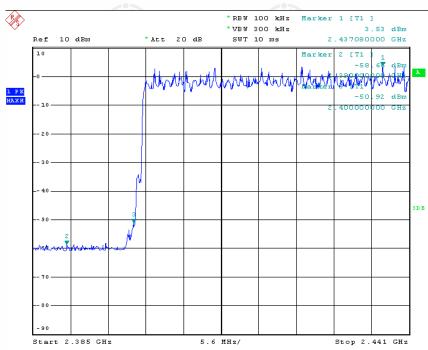




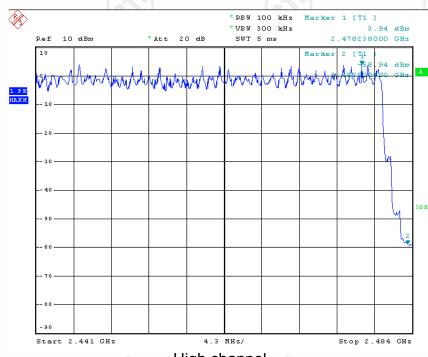


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## Hopping mode:



#### Low channel





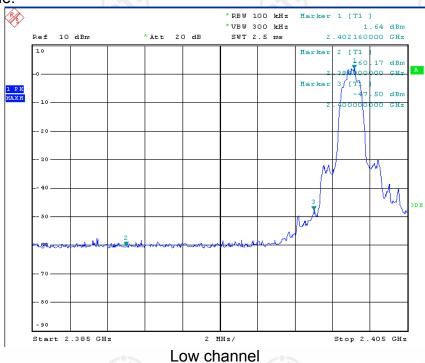


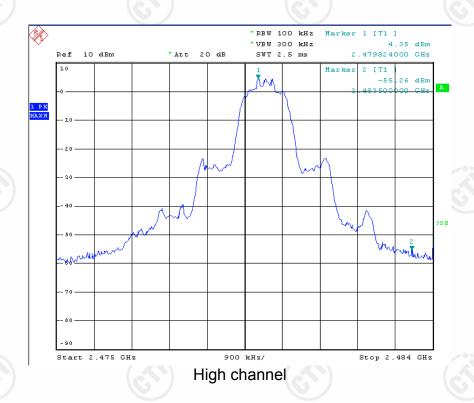




#### 8DPSK:

Hopping off mode:







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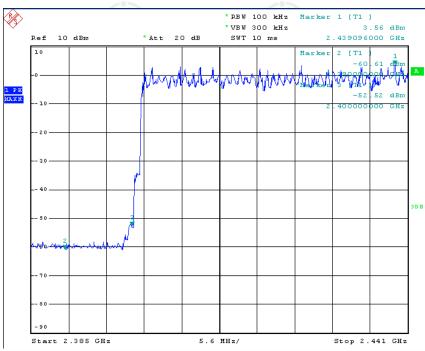




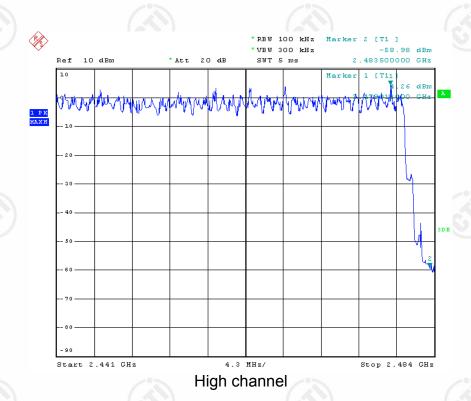


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# Hopping mode:











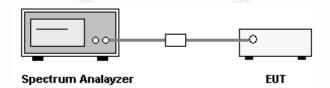


#### 13. CONDUCTED SPURIOUS EMISSION MEASUREMENT

#### 13.1. **LIMITS**

In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits.

#### 13.2. BLOCK DIAGRAM OF TEST SETUP



#### 13.3. TEST PROCEDURE

- 1. The RF output of EUT was connected to the spectrum analyzer by RF cable. The path loss was compensated to the results for each measurement.
- 2. Set to the maximum power setting and enable the EUT transmit continuously.
- 3. Set RBW = 100 kHz, VBW = 300 kHz, scan up through 10th harmonic. All harmonics / spurs must be at least 20 dB down from the highest emission level within the authorized band as measured with a 100 kHz RBW.
- 4. Measure and record the results in the test report.
- 5. The RF fundamental frequency should be excluded against the limit line in the operating frequency band.

#### 13.4. TEST RESULT

Pass.

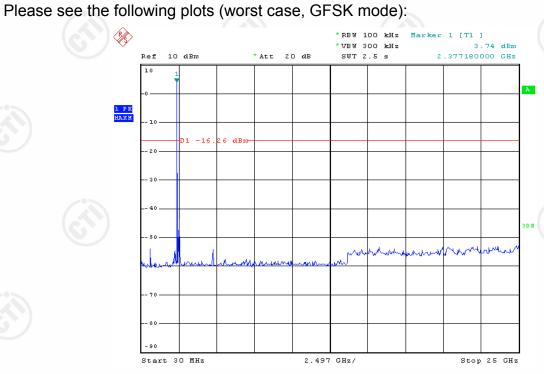




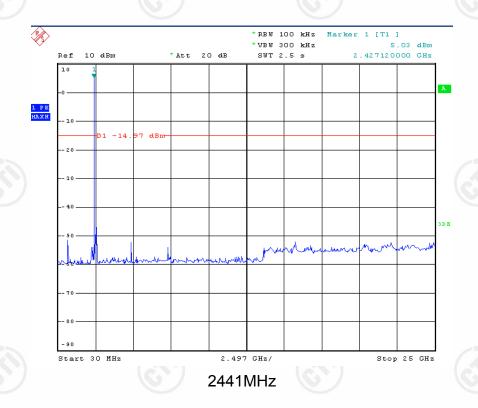














CENTRE TESTING INTERNATIONAL CORPORATION

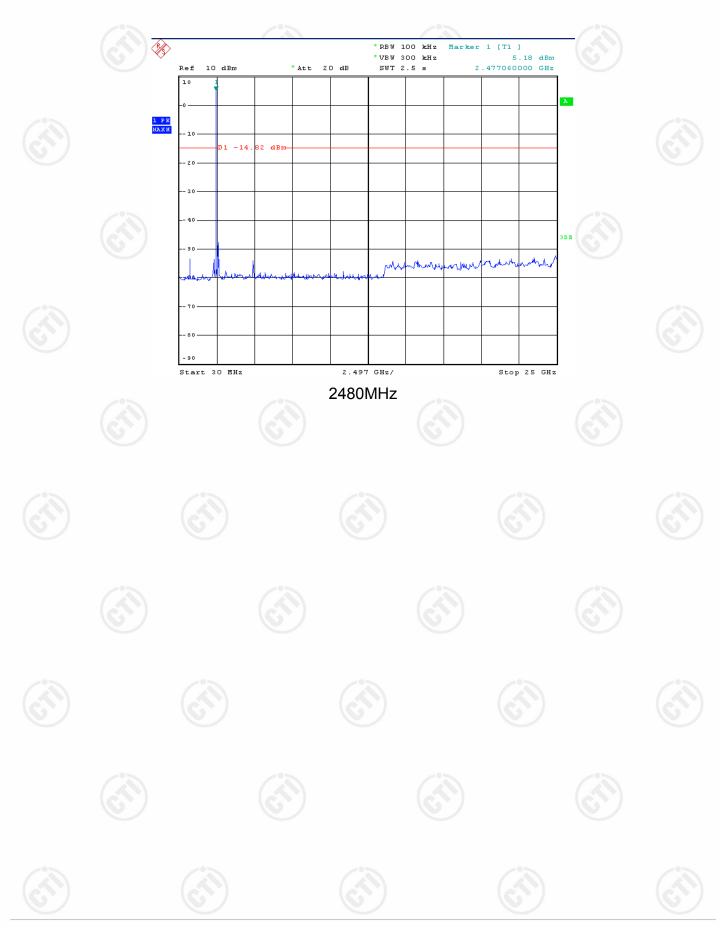








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# 14. RADIATED BANDEDGE EMISSION / RADIATED SPURIOUS EMISSION MEASUREMENT

#### 14.1. LIMITS

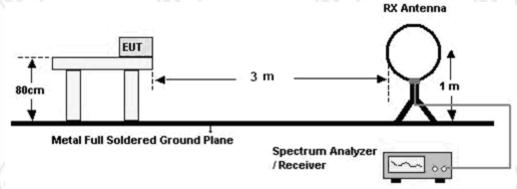
The field strength of any emissions, which appear outside of operating frequency band and restricted band specified on FCC 15.205(a), shall not exceed the general radiated emission limits as below.

431 / 431	/ 4 3 1	A 71 / A
Frequency (MHz)	Field strength (μV/m)	Distance (m)
0.009-0.490	2400/F(kHz)	300
0.490-1.705	24000/F(kHz)	30
1.705-30	30	30
30-88	100	3
88-216	150	3
216-960	200	3
Above 960	500	3

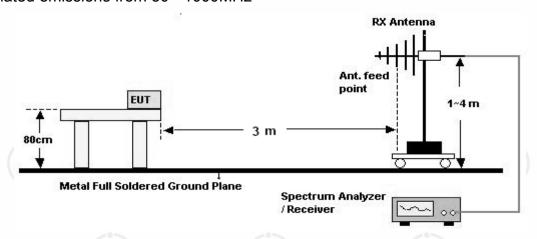
Note: the tighter limit applies at the band edges.

#### 14.2. BLOCK DIAGRAM OF TEST SETUP

For radiated emissions from 9kHz to 30MHz



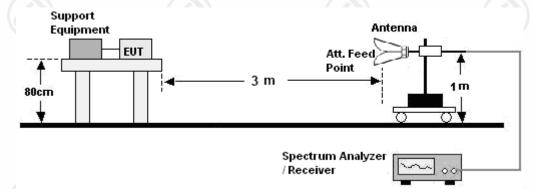
For radiated emissions from 30 - 1000MHz





For radiated emissions from 1GHz to 25GHz

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#### 14.3. TEST PROCEDURE

#### **Below 30MHz**

- a. The Product is placed on a turntable 0.8 meters above the ground in the chamber, 3 meter away from the antenna (loop antenna). The maximum values of the field strength are recorded by adjusting the polarizations of the test antenna and rotating the turntable.
- b. For each suspected emission, the Product was arranged to its worst case and then turn table was turned from 0 degrees to 360 degrees to find the maximum reading.
- c. The test frequency analyzer system was set to Peak Detect (300Hz RBW in 9kHz to 150kHz and 10kHz RBW in 150kHz to 30MHz) Function and Specified Bandwidth with Maximum Hold Mode.

#### 30MHz ~ 1GHz:

- a. The Product was placed on the non-conductive turntable 0.8m above the ground at a chamber.
- b. Set the spectrum analyzer/receiver in Peak detector, Max Hold mode, and 100 kHz RBW. Record the maximum field strength of all the pre-scan process in the full band when the antenna is varied between 1~4 m in both horizontal and vertical, and the turntable is rotated from 0 to 360 degrees.
- c. For each frequency whose maximum record was higher or close to limit, measure its QP value (120 kHz RBW): vary the antenna's height and rotate the turntable from 0 to 360 degrees to find the height and degree where Product radiated the maximum emission, then set the test frequency analyzer/receiver to QP Detector and specified bandwidth with Maximum Hold Mode, and record the maximum value.

#### Above 1GHz:

- a. The EUT was placed on the non-conductive turntable 0.8 m above the ground at a chamber.
- b. Set the spectrum analyzer/receiver in Peak detector, Max Hold mode, and 1MHz RBW. Record the maximum field strength of all the pre-scan process in the full band when the antenna is varied in both horizontal and vertical, and the turntable is rotated from 0 to 360 degrees.









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#### 14.4. TEST RESULT

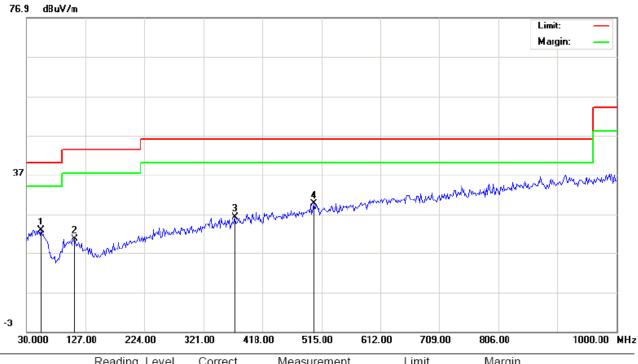
#### A. Below 30MHz:

No emissions were found higher than the background below 30MHz and background is lower than the limit, so it deems to compliance with the limit without recorded.

#### B. $30 \text{MHz} \sim 1 \text{GHz}$ :

The test data of low channel, middle channel and high channel are almost same in frequency bands 30MHz to 1GHz, and the data of middle channel (GFSK mode) are chosen as representative in below:

#### H:



No	. Freq. (dBuV)		<u> </u>						dB)					
	MHz	Peak	QP	AVG	dB	peak	QP	AVG	QP	AVG	QP	AVG	P/F Comment	
1	54.2500	6.78			16.05	22.83			40.00		-17.17		Р	
2	109.2167	7.15			13.52	20.67			43.50		-22.83		Р	
3	372.7333	7.52			18.75	26.27			46.00		-19.73		Р	
4	502.0667	8.11			21.52	29.63			46.00		-16.37		Р	







E-mail:info@cti-cert.com



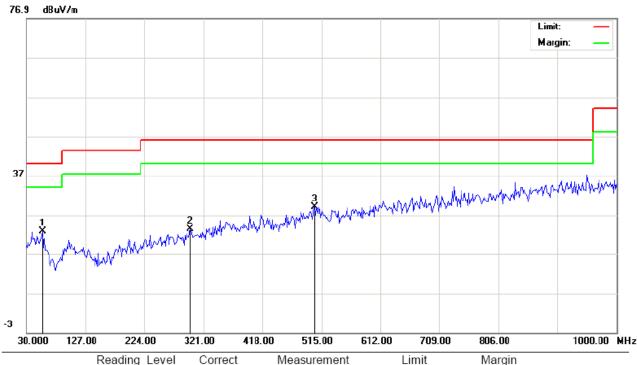






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#### V:



No	Freq.		ing_L IBuV)	evel	Correct Factor	Measurement (dBuV/m)			Limit Mar (dBuV/m) (c		rgin IB)			
	MHz	Peak	QP	AVG	dB	peak	QP	AVG	QP	AVG	QP	AVG	P/F Comment	_
1	55.8667	6.95			15.84	22.79			40.00		-17.21		Р	_
2	299.9833	6.68			16.70	23.38			46.00		-22.62		Р	
3	503.6833	7.54			21.54	29.08			46.00		-16.92		Р	_









































#### C. Above 1GHz:

Test	Results-(Me	easurement	Distance: 3	m)_Channel	low_2402M	Hz_GFSK mo	ode	
_	Mea	asurement v	/alue	Li	mit	Antenna	Result	
Frequency (MHz)	PK (dBµV/m)	AV factor (dB)	AV (dBµV/m)	PK (dBµV/m)	AV (dBµV/m)	(H/V)	(P/F)	
2390.0	36.25	N)	(c	74	54	H	Р	
2402.0	100.26					Н	Р	
2483.5	37.01			74	54	Н	Р	
4804.0	44.1			74	54	Н	Р	
		( %		(2		(8		
2390.0	36.25	(	J	74	54	V	P	
2402.0*	101.25					V	Р	
2483.5	37.12			74	54	V	Р	
4804.0	45.12		(2	74	54	V	Р	

<sup>\*:</sup> fundamental frequency

Test F	Results-(Mea	surement D	istance: 3m	_Channel m	niddle_2441	MHz_GFSK n	node	
Frequency (MHz)	Mea	asurement v	alue	Li	mit	Antenna	Result	
	PK (dBµV/m)	AV factor (dB)	AV (dBμV/m)	PK (dBµV/m)	AV (dBµV/m)	(H/V)	(P/F)	
2390.0	36.02			74	54	Н	Р	
2441.0*	102.36			·		Н	Р	
2483.5	37.25	<b>)</b>	(c	74	54	H	Р	
4882.0	45.02			74	54	Н	Р	
2390.0	36.10			74	54	V	Р	
2441.0*	104.12	(2	( )	(2	(1)	V	Р	
2483.5	37.21		J	74	54	V	Р	
4882.0	47.23			74	54	V	Р	

<sup>\*:</sup> fundamental frequency











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Test	Results-(Me	asurement	Distance: 3n	n)_Channel	high_2480M	Hz_GFSK m	ode	
_	Mea	asurement v	alue	Li	mit	Antenna	Result	
Frequency (MHz)	PK (dBµV/m)	AV factor (dB)	ΑV (dBμV/m)	PK (dBµV/m)	AV (dBμV/m)	(H/V)	(P/F)	
2390.0	36.01	(1)	(	74	54	Н	Р	
2480.0*	102.36	)		J		IJ H	Р	
2483.5	37.62			74	54	Н	Р	
4960.0	46.21			74	54	Н	Р	
	(1)							
2390.0	36.87	(6		74	54	V	Р	
2480.0*	105.96					V	Р	
2483.5	37.32			74	54	V	Р	
4960.0	44.25	(E	(	74	54	V	Р	

<sup>\*:</sup> fundamental frequency

#### Remark:

- 1. The above tables show that the frequencies peak data are all below the average limit, so the average data of these frequencies are deems to fulfill the average limits and not reported.
- 2. All the modes of GFSK,  $\pi$ /4-DQPSK and 8DPSK have been tested. The worst case is GFSK mode, and the worst data of GFSK mode are chosen as above.
- 3. No emission found from 18GHz to 25GHz.
- 4. All outside of operating frequency band and restricted band specified are below 15.209.







# 15. AC CONDUCTED EMISSION TEST 15.1. LIMITS

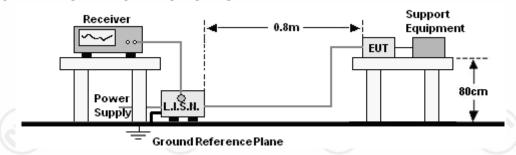
**Limits for Class B digital devices** 

Frequency range (MHz)	Limits dB(μV)							
	Quasi-peak	Average						
0,15 to 0,50	66 to 56	56 to 46						
0,50 to 5	56	46						
5 to 30	60	50						

**NOTE:** 1. The lower limit shall apply at the transition frequencies.

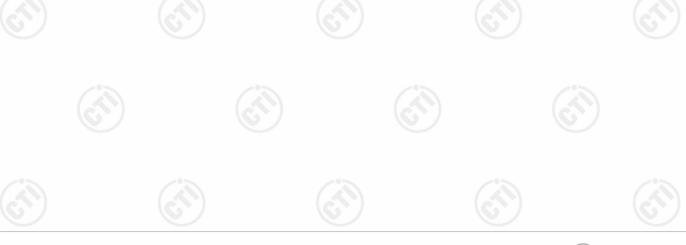
2. The limit decreases linearly with the logarithm of the frequency in the range 0.15 to 0.50 MHz.

#### 15.2. BLOCK DIAGRAM OF TEST SETUP



#### 15.3. PROCEDURE OF CONDUCTED EMISSION TEST

- a. The Product was placed on a nonconductive table above the horizontal ground reference plane, and 0.4 m from the vertical ground reference plane, and connected to the main through Line Impedance Stability Network (L.I.S.N).
- b. The RBW of the receiver was set at 9 kHz in 150 kHz ~ 30MHz with Peak and AVG detector in Max Hold mode. Run the receiver's pre-scan to record the maximum disturbance generated from Product in all power lines in the full band.
- c. For each frequency whose maximum record was higher or close to limit, measure its QP and AVG values and record.









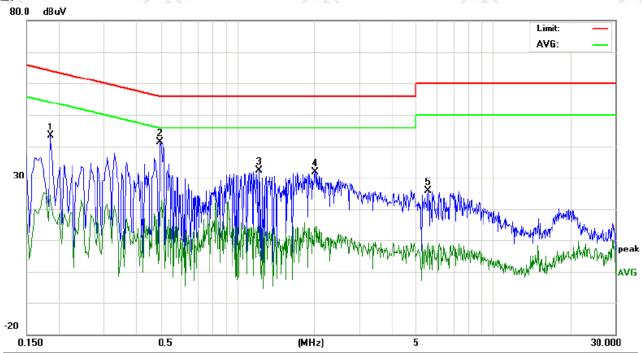


### 15.4. GRAPHS AND DATA

Power : DC 5V Temperature : 23°C

Mode : Keeping TX Humidity : 52%





No.	Reading_Level o. Freq. (dBuV)			Correct Factor				Lin (dB			rgin dB)			
	MHz	Peak	QP	AVG	dB	peak	QP	AVG	QP	AVG	QP	AVG	P/F	Comment
1	0.1860	33.51		14.71	9.79	43.30		24.50	64.21	54.21	-20.91	-29.71	Р	
2	0.4980	31.60		8.58	9.80	41.40		18.38	56.03	46.03	-14.63	-27.65	Р	
3	1.2180	22.53		5.16	9.82	32.35		14.98	56.00	46.00	-23.65	-31.02	Р	
4	2.0220	22.09		4.77	9.90	31.99		14.67	56.00	46.00	-24.01	-31.33	Р	
5	5.5780	15.96		-0.96	10.00	25.96		9.04	60.00	50.00	-34.04	-40.96	Р	





























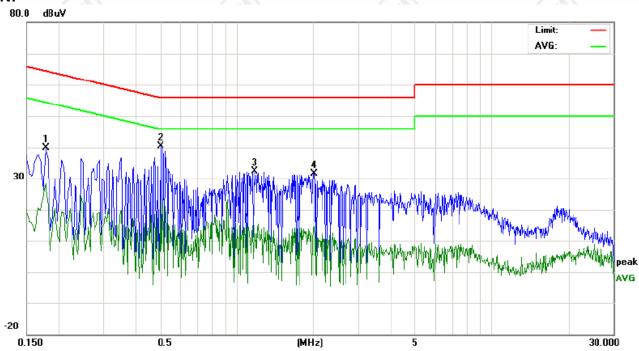


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N:



No.	Freq.	Reading_Level (dBuV)			Correct Factor	Measurement (dBuV)			Limit (dBuV)		Margin (dB)			
	MHz	Peak	QP	AVG	dB	peak	QP	AVG	QP	AVG	QP	AVG	P/F	Comment
1	0.1780	30.03		18.66	9.78	39.81		28.44	64.57	54.57	-24.76	-26.13	Р	
2	0.5020	30.65		13.24	9.80	40.45		23.04	56.00	46.00	-15.55	-22.96	Р	
3	1.1780	22.44		5.20	9.82	32.26		15.02	56.00	46.00	-23.74	-30.98	Р	
4	2.0220	21.80		5.06	9.90	31.70		14.96	56.00	46.00	-24.30	-31.04	Р	







































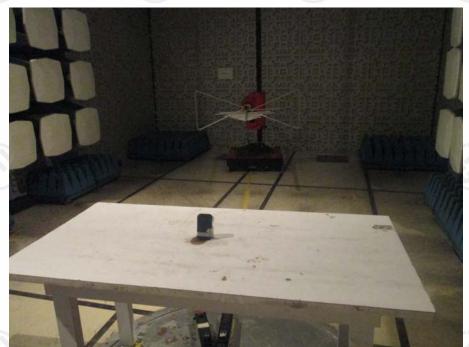








# **APPENDIX 1 PHOTOGRAPHS OF TEST SETUP**



TEST SETUP OF RADIATED EMISSION (30MHz-1GHz)



**TEST SETUP OF RADIATED EMISSION (above 1GHz)** 



















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TEST SETUP OF CONDUCTED EMISSION































































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# **APPENDIX 2 EXTERNAL PHOTOGRAPHS OF PRODUCT**



Fig.1- General View



Fig.2- General View















Fig.3- General View



Fig.4- General View











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Fig.5- General View























































# **APPENDIX 3 INTERNAL PHOTOGRAPHS OF PRODUCT**



Fig.1- Terminal View



Fig.2- Inner View





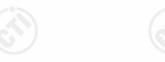






Fig.3- Inner View

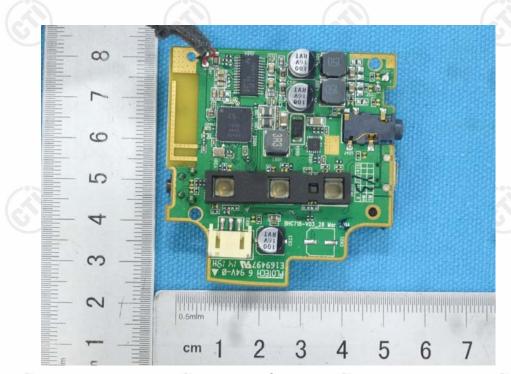


Fig.4- PCB View















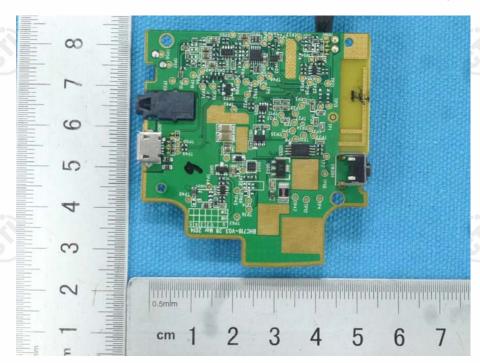


Fig.5- PCB View

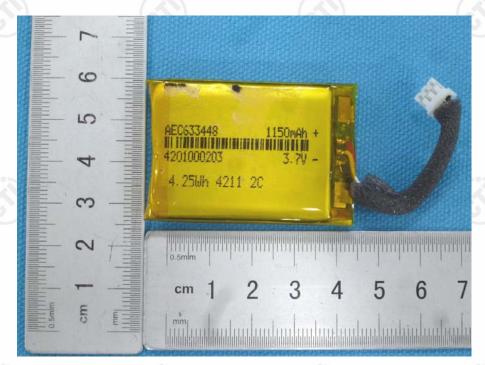


Fig.6- Battery View

#### \*\*\* End of Report \*\*\*

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